Difração de Raios X Principais aplicações

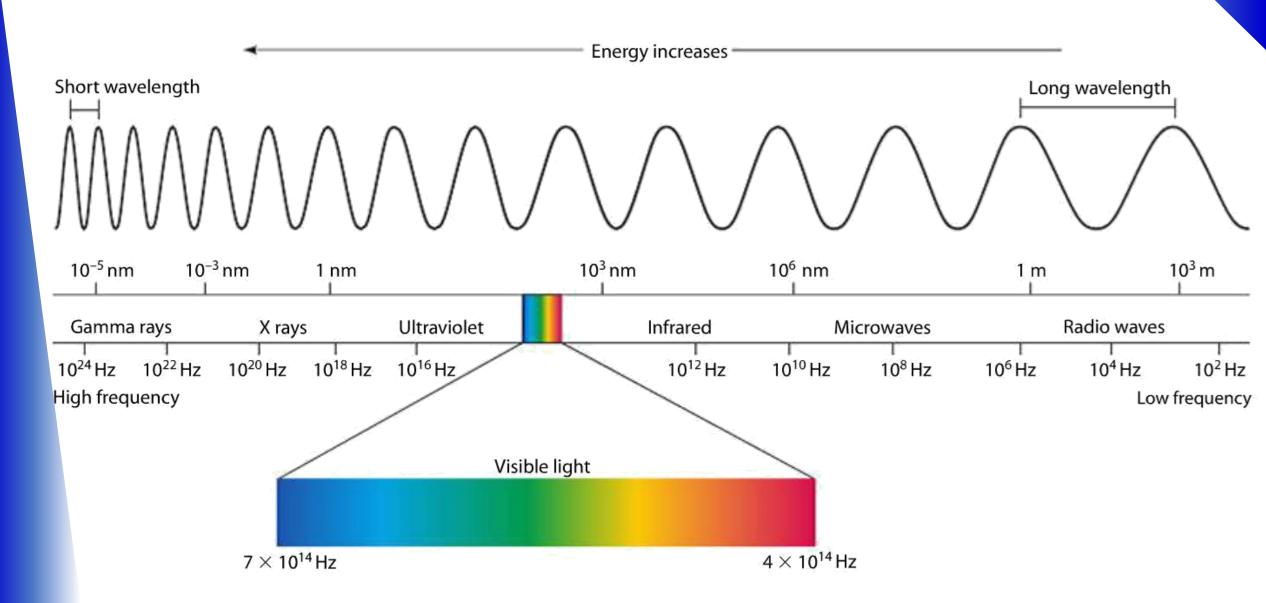
- Identificação de materiais
- Análises químicas
- Análise de estruturas cristalinas
- Determinação da estrutura cristalina
- Distinção das diferentes estruturas alotrópicas de elementos químicos
- Quantificação de fases
- Caraterização do material (ex: tamanho das cristalites)

X-ray diffraction Main applications

- Identification of materials
- Chemical analyses
- Analysis of crystalline structures
- Determination of the crystalline structure
- Distinction of the different allotropic structures of chemical elements
- Quantification of phases
- Characterization of the material

(ex: crystallite size)

Espetro da radiação eletromagnética Spectrum of electromagnetic radiation



Wilhelm Conrad Röntgen (1845-1923), em 1895, com uma foto tirada com raios X mostrando a mão e o anel da esposa. A descoberta da radiação X valeu-lhe o prémio Nobel da Física em 1901.

Wilhelm Conrad Röntgen (1845-1923), in 1895, with a photo taken with X-rays showing his wife's hand and ring. The discovery of X-radiation earned him the Nobel Prize in Physics in 1901.

Descoberta da radiação X Discovery of Radiation X



Equipamento radiológico de hospital Hospital Radiological Equipment

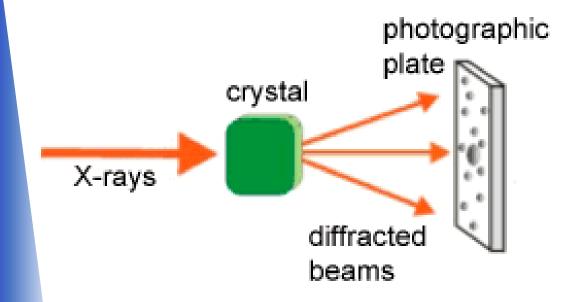
Difração de Raios X X-Ray diffraction

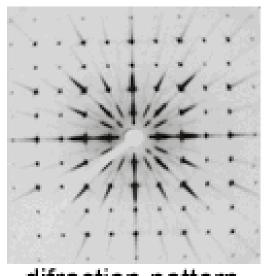
Alguns anos após a descoberta da radiação X em 1895, Max von Laue, em 1912, revoluciona as áreas da Física, Química e Biologia com uma nova descoberta.

A few years after the discovery of X-radiation in 1895, Max von Laue, in 1912, revolutionized the fields of Physics, Chemistry and Biology with a new discovery.

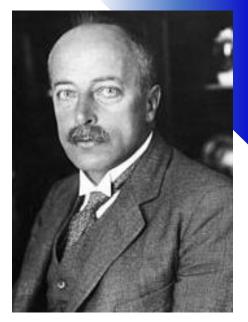
O fenómeno da difracção

The diffraction phenomenon





difraction pattern



Max von Laue (1879-1960)

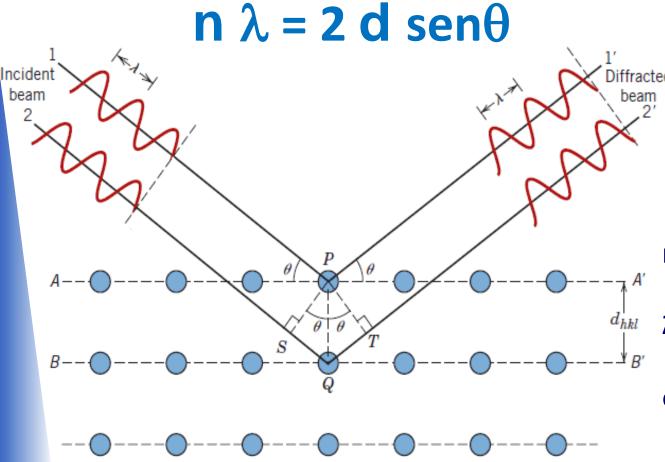
von Laue placed copper sulfate crystals in the X-radiation path and obtained a characteristic diffraction pattern. For his discoveries, he won the Nobel Prize in Physics in 1914.

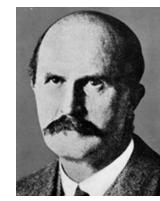
von Laue colocou cristais de sulfato de cobre no caminho da radiação X e obteve um padrão de difração característico. Pelas suas descobertas ganhou o Prémio Nobel da Física em 1914.

Difração de Raios X X-ray diffraction

Lei de Bragg

Bragg's law







W.H. Bragg (1862-1942) W.L Bragg (1890-1971)

Pai e filho receberam o Prémio Nobel da Física em 1915, pela descoberta de que sólidos cristalinos produziam padrões de reflexão de raios X.

Father and son were awarded the Nobel Prize in Physics in 1915 for the discovery that crystalline solids produced X-ray reflection patterns.

- **n** número inteiro de comprimento de onda integer number of wavelenghts
- λ comprimento de onda da radiação X (1.54 Å) wavelenght of radiation X (1.54 Å)
- **d**_{hkl} distância entre planos atómicos distance between atomic planes
- θ ângulo de Bragg / Bragg's angle

Pure metal

anode

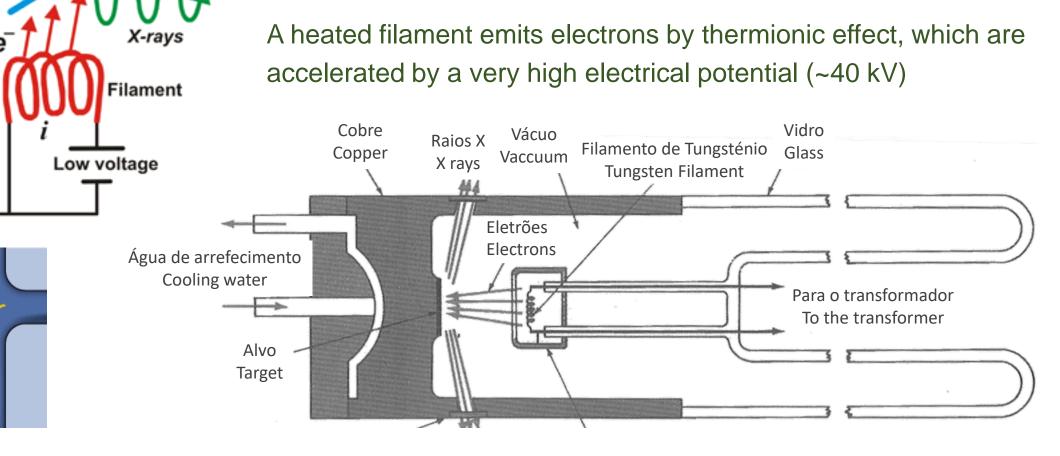
Origem da radiação X Origin of radiation X

High voltage

X-ray Diffraction

Ampola para produção de radiação X Ampoule for production of radiation X

Um filamento aquecido emite electrões por efeito termiónico, que são acelerados por um potencial eléctrico muito elevado (~40 kV)

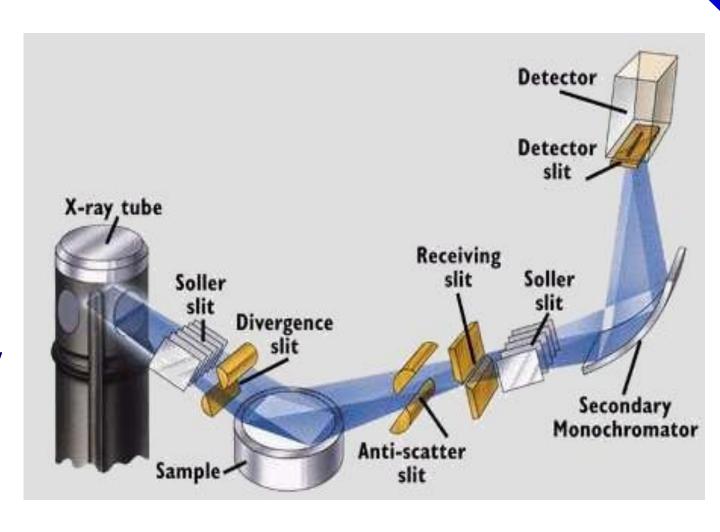


Os **difratómetros** em geral são constituídos por:

- Refrigerador / Refrigerator
- Fonte de eletricidade / Electricity source
- ❖ Tubo gerador de Raio X / X-Ray Generator Tube
- Câmara da amostra / Sample Chamber
- ❖Detetor da intensidade de Raio X /
- X-ray Intensity Detector
- Goniómetro / Goniometer
- Computador(es) / Computer(s)

X-Ray diffraction

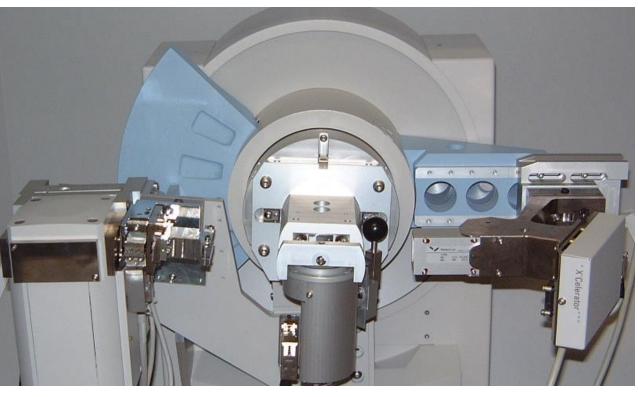
Diffractometers in general consist of:



X-Ray diffraction

Difratómetros Difractometers





Difração de Raios X X-Ray diffraction

Materiais cristalinos e não cristalinos

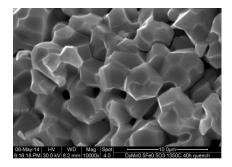
Crystalline and non-crystalline materials

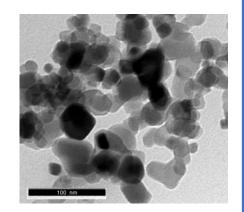
Materiais monocristalinos Monocrystalline materials





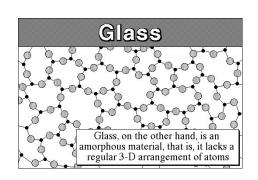
Materiais policristalinos Polycrystalline materials





Materiais nanocristalinos Nanocrystalline materials

Materiais amorfos Amorphous materials



Acerca da amostra a analisar

- Conhecemos a composição química?
- A amostra é pura ou é uma mistura?
- A amostra é um pó, um pedaço de metal/liga, um filme?
- A amostra pode ser moída, ou tem de ser analisada como está?
- A amostra tem fases amorfas?
- A amostra contém nanopartículas?
- Que quantidade de amostra temos?
- Para que servem os resultados obtidos?

X-Ray diffraction

About the sample to be analysed

- Do we know its chemical composition?
- Is the sample pure or is it a mixture?
- Is the sample a powder, a piece of metal/alloy, a film?
- Can the sample be ground, or does it have to be analysed as is?
- Does the sample have amorphous phases?
- Does the sample contain nanoparticles?
- What quantity of sample do we have?
- What are the results for?



Home ((According Mode) Analytical Fields (Internation/Acapton February) Analytic Request (Internation/Acapton) Prices (Internation/Acapton) Prices (Internation/Acapton)

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ANALYTICAL LABORATORY





The Laboratorio de Análises was created in 2002 to offer analytical support to the Laboratorio Associado para a Sulmica Vertie - Associated Laboratory for Green Chemistry REQUIATE - Network of Chemistry and Technology the May require on the Information and research units, and companies as well as those that are interested in the available services. The main propose of the Laboratory is to support research, providing infrastructure and knowledge for science and innovation. This framework allows the development of analysis methodologies in a wide spectrum of areas. Furthermore, the Laboratory is determined in the efficiency of response in the shortest time possible.

https://sites.fct.unl.pt/labanalises/biocv

Responsável/Responsible: Nuno Costa

(ver/watch video)

Equipamento disponível no DQ/FCT Equipment available at DQ/FCT

XRPD - X-Ray Powder Difraction

Equipment



Benchtop X-Ray Diffractometer RIGAKU, model MiniFlex II with:

Cu X-ray tube (30KV/15 mA) Scanning range: 3~ +145° (2θ)

Scanning speed: 0,01~+100°/min (20)

Minimum step width: 0,01° (2θ).

Samples

Samples in dry powder form and homogeneous. The samples should be supplied of the sample plate.

Difração de Raios X X-Ray diffraction

Preparação da amostra Sample preparation



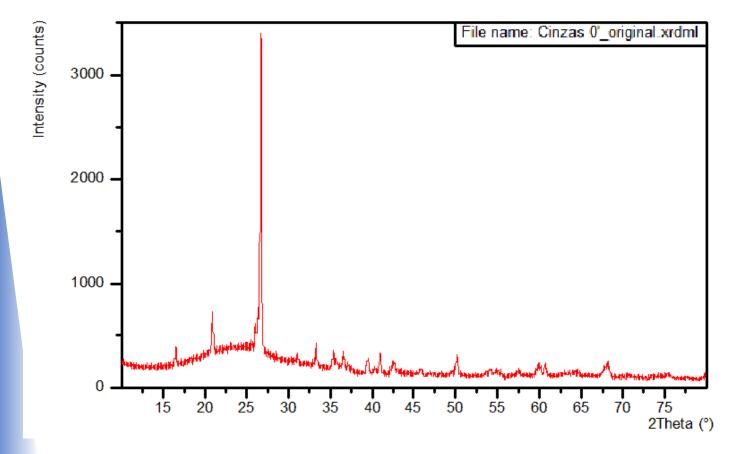


X-Ray diffraction

Obtenção do difratograma

Obtaining the diffractogram

Sempre que um plano cristalográfico da amostra satisfaz a lei de Bragg, obtém-se uma difração que se traduz num pico de radiação X captado pelo detetor. No gráfico representase o número de contagens (de radiação X) obtidas em função do ângulo 2θ.



Whenever a crystallographic plane of the sample satisfies Bragg's law, a diffraction is obtained that translates into a peak of X-radiation captured by the detector. The graphic shows the number of counts (of X-radiation) obtained as a function of the 2θ angle.

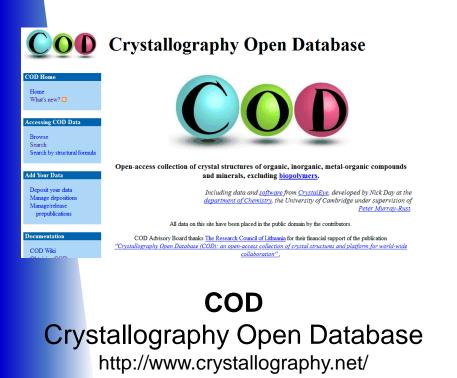
Identificação dos picos

X-Ray diffraction

Peak identification

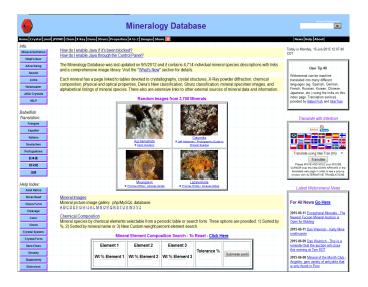
A interpretação é efetuada comparando o espetro obtido (posição e intensidade dos picos de difração) com estruturas cristalográficas de bases de dados (ex: fichas ASTM – American Society of Testing Materials, bases de dados online – algumas gratuitas)

The interpretation is performed by comparing the obtained spectrum (position and intensity of diffraction peaks) with crystallographic structures from databases (e.g. ASTM – American Society of Testing Materials sheets, online databases – some free)



	American A	Nineralogist Cry	vstal Structure Database	
Mineralogist, Euro	pean Journal of Mineralogy and ained under the care of the Mine	Physics and Chemistry	y structure published in the American Mineralogist r of Minerals, as well as selected datasets from oth ierica and the Mineralogical Association of Canada,	er journals. The
			<u>Mineral</u>	
			Author	
			Chemistry Search	
			Cell Parameters and Symmetry	
			<u>Diffraction Search</u>	
			General Search Search Tips	
		Search	Reset	
	Logic interface	● AND ○ OR		
	Viewing (About File Formats)	• amc long form •	amc short form O cif	
	Download	• amc o cif o dif	fraction data	
	-			

American Mineralogist Crystal Structure Database http://rruff.geo.arizona.edu/AMS/amcsd.php



Mineralogy Database http://webmineral.com/

Identificação dos picos

❖ Havendo conhecimento prévio da natureza química dos compostos a identificar, usa-se uma lista de substâncias por ordem alfabética. (d_{hkl} e l_{hkl} das fichas ASTM, têm que coincidir com as do composto a identificar).

❖Método das 3 riscas mais intensas

A risca mais intensa permite selecionar um grupo de substâncias e depois passa-se sucessivamente às menos intensas até se chegar a um número reduzido de substâncias.

Consultam-se as fichas ASTM com todos os valores de d e hkl idênticos.

X-Ray diffraction

Peak identification

❖If there is previous knowledge of the chemical nature of the compounds to be identified, a list of substances is used in alphabetical order.

 (d_{hkl}) and I_{hkl} of the ASTM sheets, must match those of the compound to be identified).

❖Method of the 3 most intense lines

The most intense line allows to select a group of substances and then move on to the less intense ones until reaching a small number of substances.

The ASTM sheets with all the identical d and hkl values are consulted.

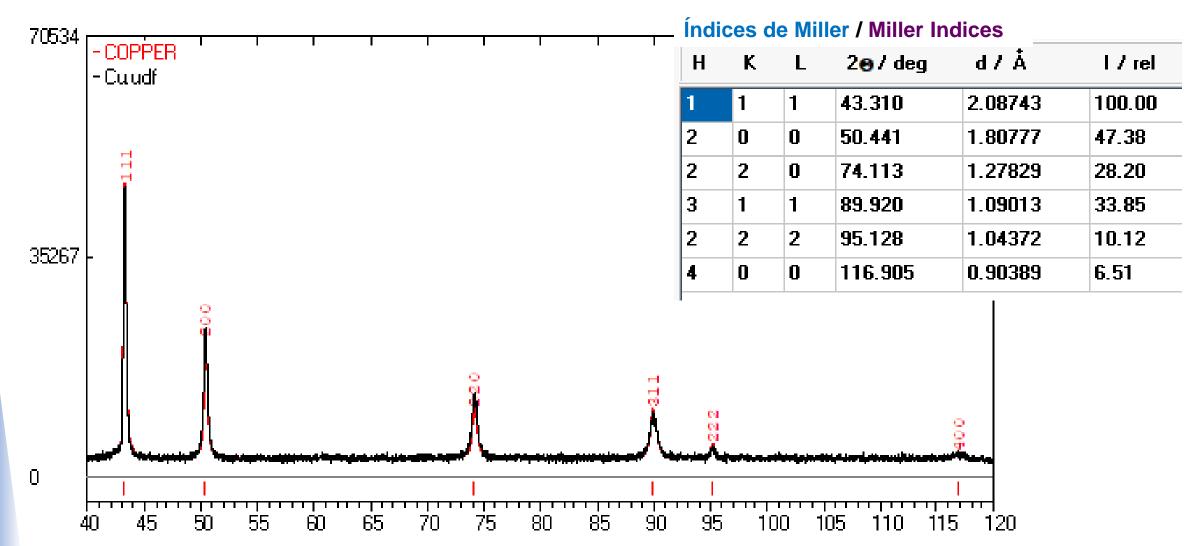
Difração de Raios X X-Ray diffraction

Exemplo de difratograma obtido experimentalmente

Example of an experimentally obtained diffractogram

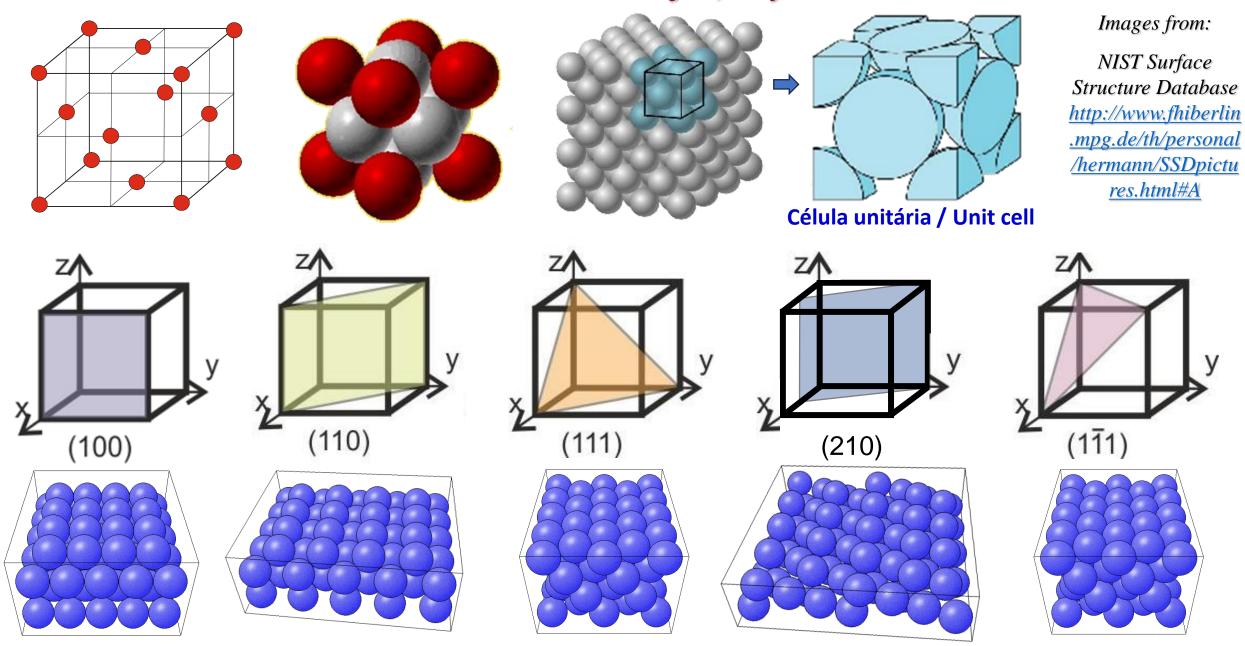
COPPER

COBRE



Os planos cristalinos são dados pelos índices de Miller (hkl) que são coordenadas nas quais o plano interceta os eixos x, y e z Crystal planes are specified by the Miller indices (hkl) that are coordinates at which the plane (001)(200)intercepts the x, y and z axes (101)plane (hkl) plano (hkl) Planos obtidos calculados pelo inverso das coordenadas Planes obtained by the reciprocal of intercepts

Ex: Face centred cubic (fcc) crystal structure



Surfaces generated with Surface Explorer: http://surfexp.fhi-berlin.mpg.de/

Difração de raios X X-Ray diffraction Fórmula de Scherrer

Scherrer's formula

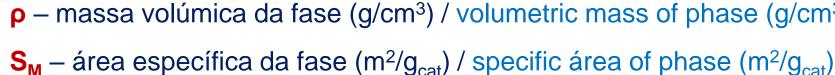
 $\pi \text{ rad} = 180^{\circ}$

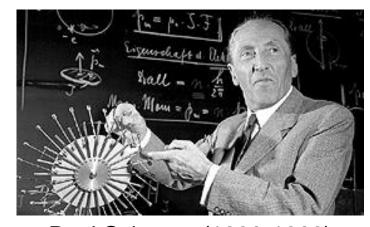
$$dp = \underline{\beta \lambda} = \underline{6 y}$$

$$b \cos\theta = \rho S_{M}$$

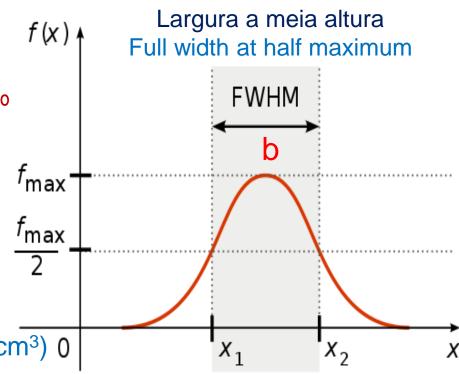
dp – diâmetro das cristalites / crystallite diameter

- β constante que depende da forma das cristalites (em geral = 1) constant that depends on crystallite shape (in general = 1)
- λ comprimento de onda da radiação X (1.54 Å) wavelenght of radiation X (1.54 Å)
- **b** largura a meia altura do pico mais intenso (em radianos) full width at half maximum of the most intense peak (in radians)
- θ − ângulo de Bragg (em radianos) / Bragg's angle (in radians)
- y fração ponderal do metal no catalisador / weight fraction of metal in catalyst
- p massa volúmica da fase (g/cm³) / volumetric mass of phase (g/cm³) 0





Paul Scherrer (1890-1969)



Fórmula de Scherrer

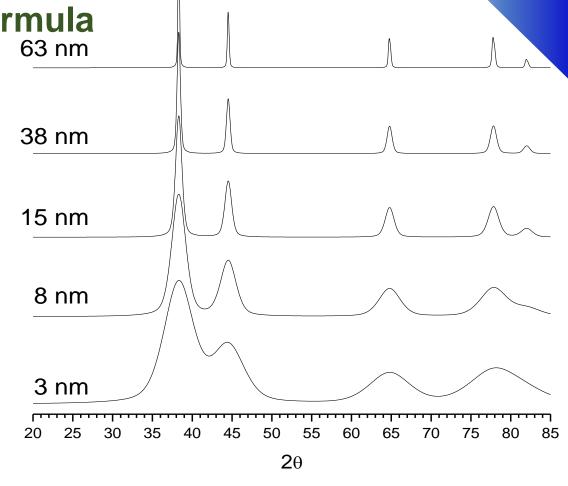
X-Ray diffraction Scherrer's formula

$$dp = \beta \lambda = 6y$$

$$b \cos\theta = \rho S_M$$

dp – diâmetro das cristalites / crystallite diameter

- β constante que depende da forma das cristalites (em geral igual a 1) constant that depends on crystallite shape (in general equal to 1)
- \(\lambda\) comprimento de onda da radiação X (1.54 Å) wavelenght of radiation X (1.54 Å)
- **b** largura a meia altura da banda de difração de raios X (em radianos) full width at half maximum (in radians, π rad = 180°)
- θ − ângulo de Bragg (em radianos) / Bragg's angle (in radians)
- y fração ponderal do metal no catalisador weight fraction of metal in catalyst
- p massa volúmica da fase (g/cm³) / volumetric mass of phase (g/cm³)
- ${
 m S_M}$ área específica da fase (m²/g $_{
 m cat}$) / specific área of phase (m²/g $_{
 m cat}$)



Picos altos e estreitos partículas maiores
Tall and narrow peaks larger particles

Picos baixos e largos Small and broad peaks

partículas menores smaller particles

Outros cálculos

X-Ray diffraction

Other calculations

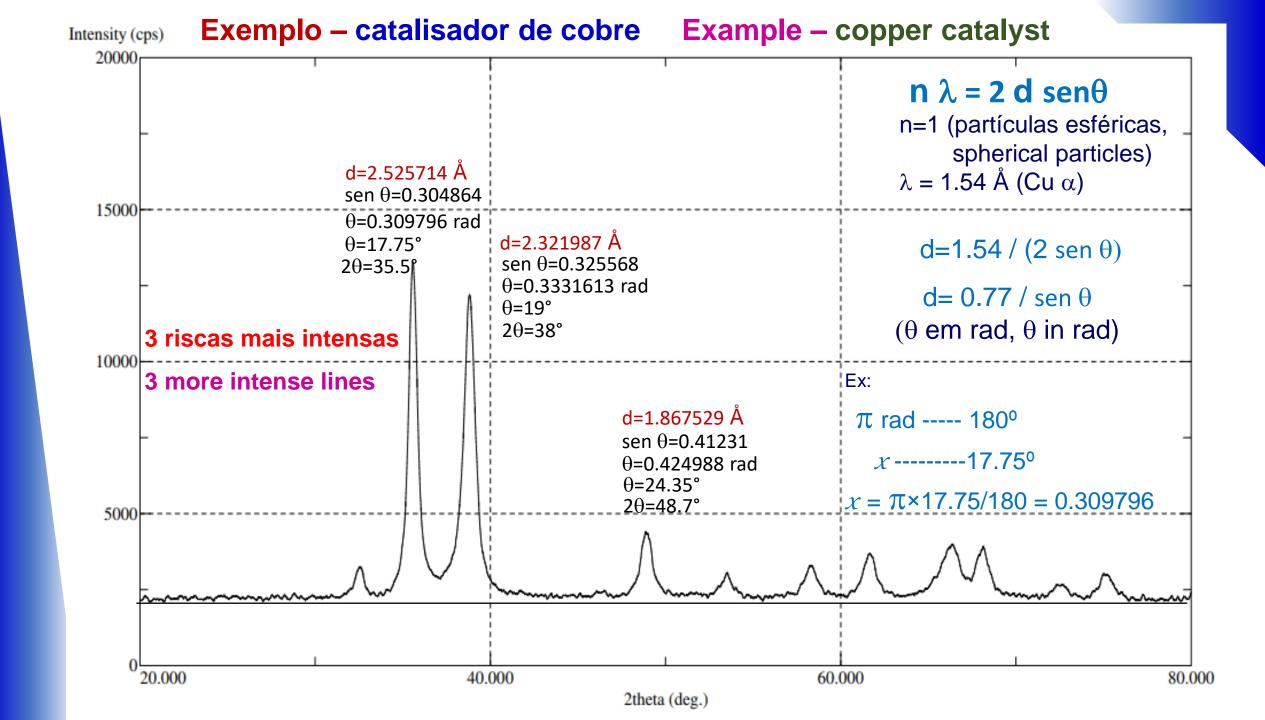
Sabendo, S_M, a **dispersão D_M** é dada por:

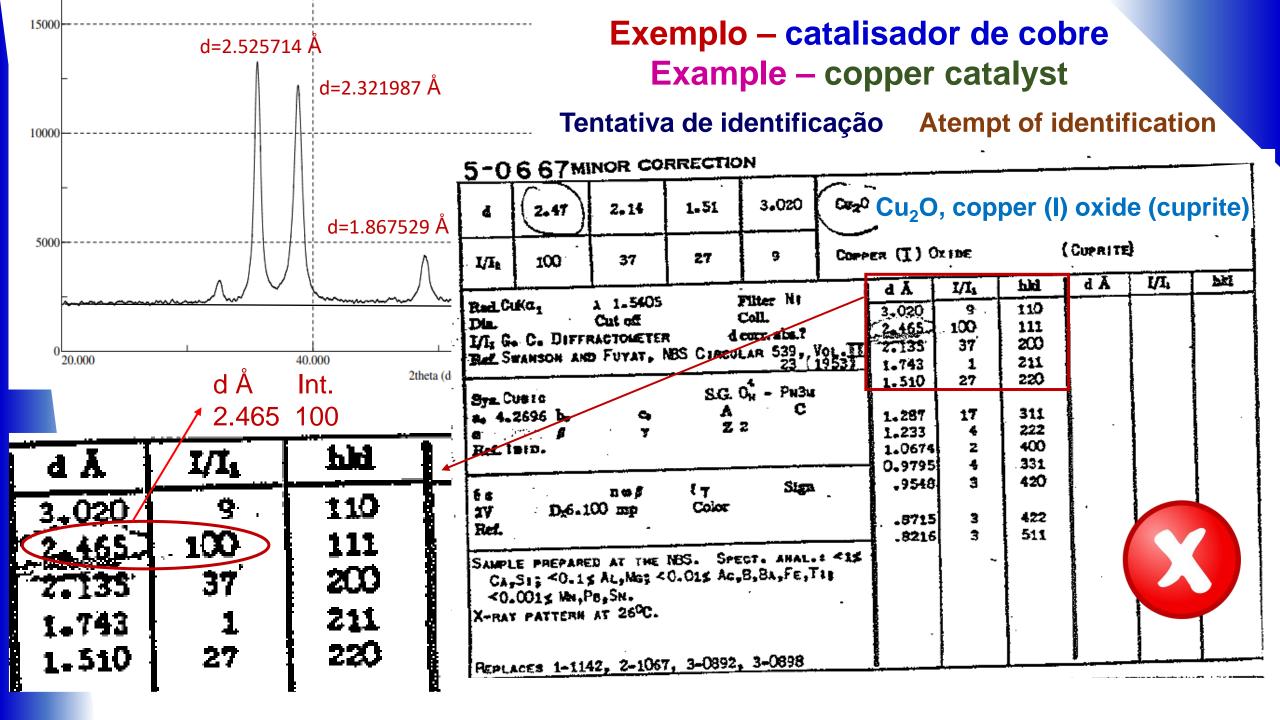
$$D_{M} = \underbrace{S_{M} n_{s}}_{N y/M}$$

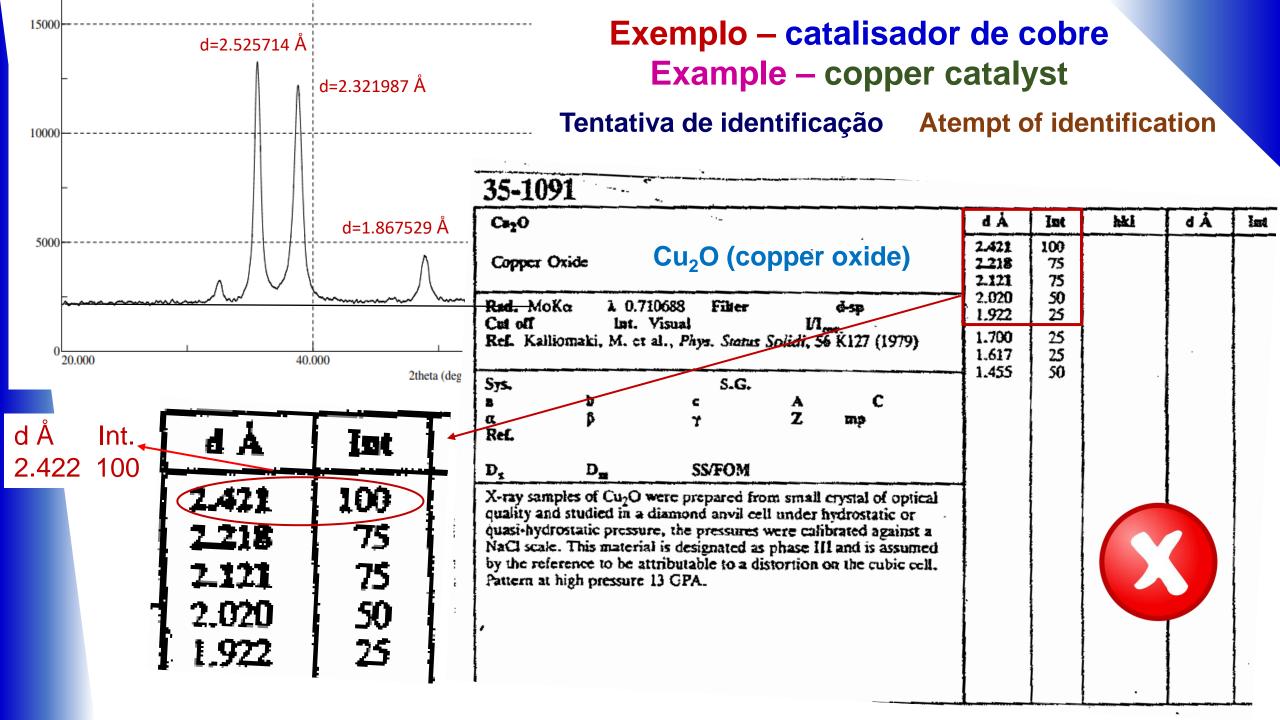
Knowing, S_M , the **dispersion D_M** is given by:

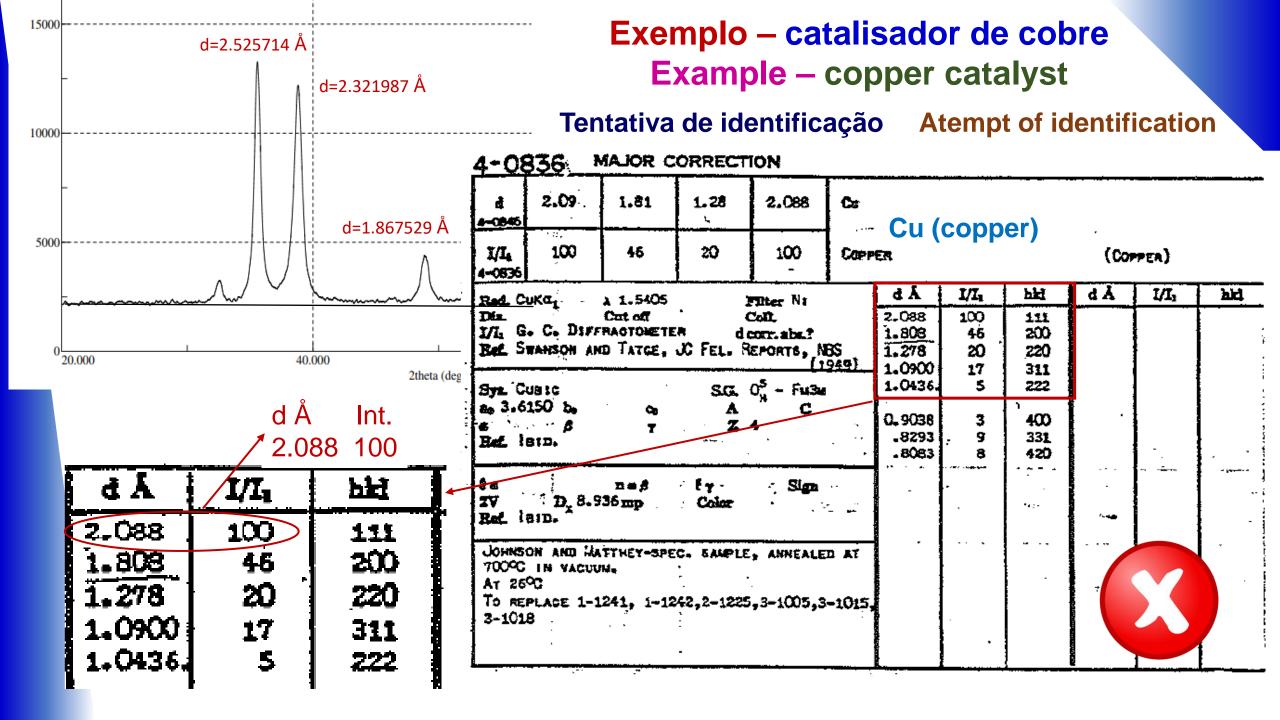
D_M é adimensional **D**_M is dimensionless

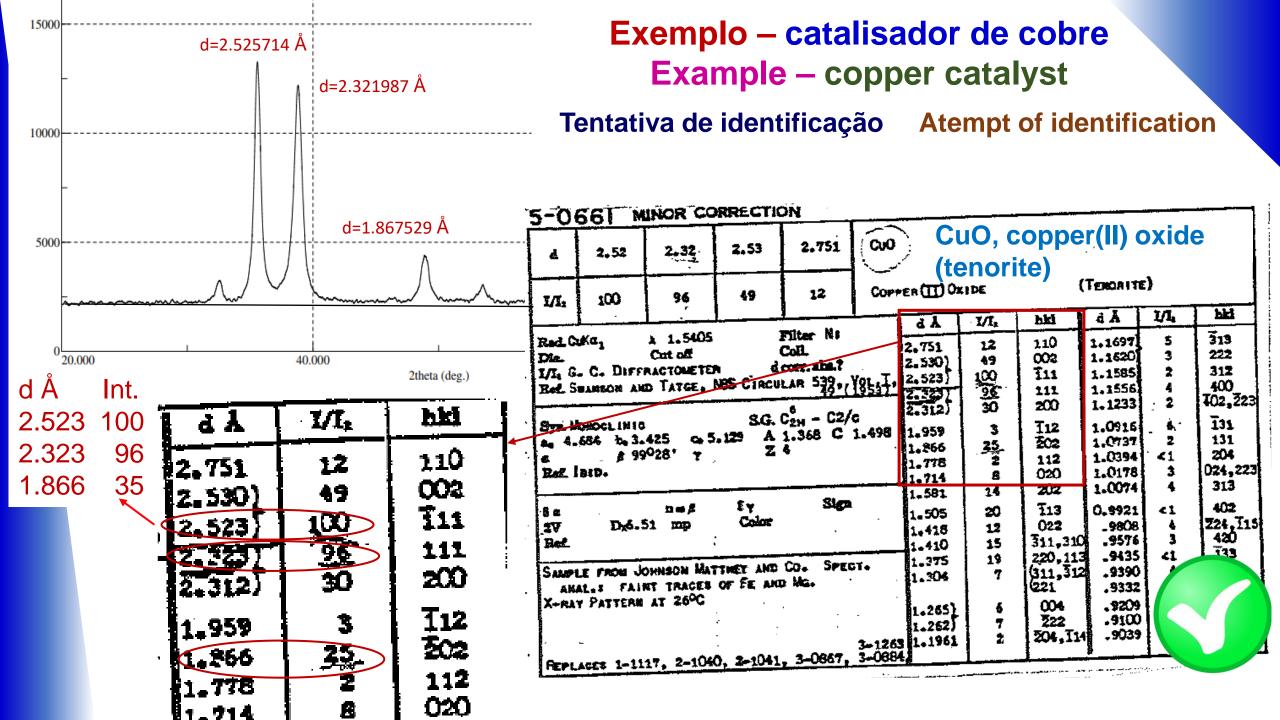
- S_{M} área específica da fase (m²/g_{cat}) / specific área of phase (m²/g_{cat})
- n_s número tabelado de átomos na superfície por unidade de área (átomos/m²) tabulated number of atoms on the surface per unit area (atoms/m²)
- N número de Avogrado / Avogrado's number (6.023 ×10²³ átomos/mol)
- y fração ponderal do metal no catalisador / weight fraction of metal in catalyst
- M massa atómica de cada fase (g/mol) / atomic mass of phase (g/mol)





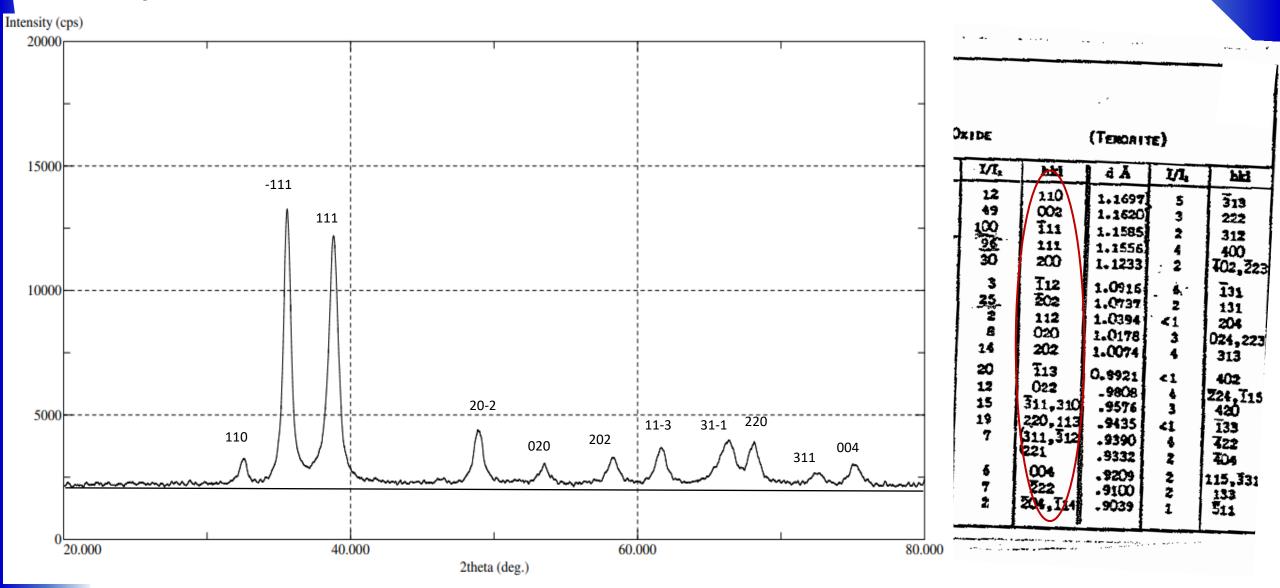






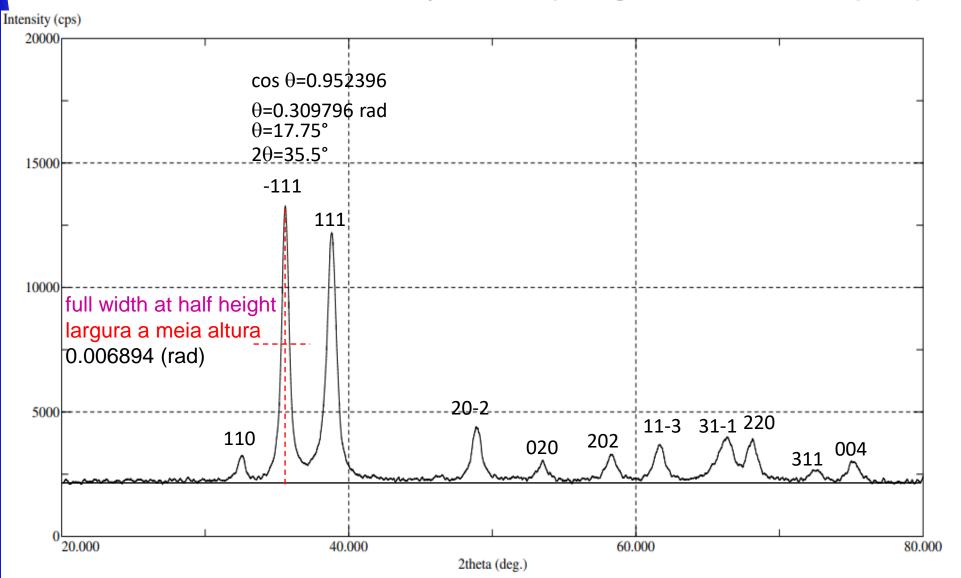
CuO (óxido de cobre (II), tenorite) CuO (copper oxide (II), tenorite)

Identificação dos índices de Miller dos picos / Identification of Miller indices of peaks



CuO (óxido de cobre (II), tenorite) CuO (copper oxide (II), tenorite)

Cálculo do diâmetro das cristalites (usando o pico mais intenso)
Calculation of the diameter of crystallites (using the most intense peak)



$$dp = \frac{\beta \lambda}{b \cos \theta}$$

$$\beta = 1$$
 $\lambda = 1.54 \text{ Å}$

$$\theta$$
 = 0.309796 rad

$$\cos \theta = 0.952396$$

$$b = 0.006894 \text{ rad}$$

$$dp = 234.55 \text{ Å}$$

$$dp = 23.45 \text{ nm}$$

Exemplo – catalisador de cobalto Example – cobalt catalyst

De acordo com os seguintes dados de difração de Raios X obtidos para um catalisador com 1% de Cobalto suportado em carvão ativado.

According to the following X-ray diffraction data obtained for a catalyst with 1% Cobalt supported on activated carbon.

- a) Identifique as fases presentes no suporte / Identify the phases present in the support.
- b) Determine o tamanho das partículas do metal, a área metálica e a dispersão metálica. Considere a largura a meia altura do pico mais intenso do metal, igual a 10° (2θ)

Determine the size of the metal particles, the metal area, and the metal dispersion. Consider the width at half height of the metal's most intense peak, equal to 10° (20)

2 θ	I /I ₀	hkl	d
36,48	75	111	
42,38	100	200	
44,14	100	111	
51,59	40	200	
61,50	50	220	
73,65	20	311	
76,08	30	220	
92,09	30	311	
98,08	10	222	

c) Como procederia para obter a área metálica usando outras técnicas de caracterização? Justifique.

How would you proceed to obtain the metallic area using other characterization techniques? Justify.

$$n_s$$
=1.51x 10¹⁹ atoms/m²
 ρ = 8.9 g/cm³
M = 58.9 g/mol
 λ = 1.54 Å

a) Identifique as fases presentes no suporte. Identify the phases present in the support.

	2 0	I/I ₀	hkl	d	9-4	02						_ -
	36,48 42,38	75 100	111 200	2.46	d	2.13	2,46	1.51	2.46	(00)		:
	44,14	100	111	2.05					75	COBALT (II)	Oxide	
	51,59 61,50	40 50	200 220	1.77	1/1,	100	75	50	<u> </u>		d Å 1/L	hk
	73,65	20	311	1.28		_	1.7889 I/I ₁ Di	Filter FFRACTOME	TÉR		2.460 75 2.130 100	111 200
	76,08 92,09	30 30	220 311	1.25	Ref	NAT. BUR.	. STANDARI			 	2.130 100 1.5062 50 1.2846 20	311
	98,08	10	222	1.02	Sys.	Cuaic .260	ba	\$.G. C4	OH - FM3	C	1.2298 15 1.0651 9	1
1 2	$\lambda = 2 d sen$	ıθ ⇔ d=	= 0.77/s	$en\theta (\theta, ra)$	ad)	B D•	β	Y	Z 4	Dx 6.437	0.9775 13	331
		1 /		· · · ·		1012.		<u></u>		CO	c.f.c. (>45	-

1.77	1.07	2	(co)4 <u>F</u>				- ,
40	30	100	Cobalt (cubic)			<u>*</u>
	Filter iffractom ono. 25,		2.0167 1.7723 1.2532	140°	111 200 220	-	
	S.G.	Fe.3a	(No. 225)	1.0688	30	311	AND

	· ;	D	D mp		£ ·		Color BLA	
ki	 	100	100	90	Coo	ALT 10 0	DX IDE	
222 220 311 211	AND	A 0.709 Cut off STRADA, (1928)		Filter Coll. corr. abs.?	58	d Å 3.21 2.87 2.33 1.78	1/I ₄ 90 100 100 100	_
 .e	_ ·	(Яножно.	?) S.G. 5.75 A Z	C	1.24	1.63 1.57 1.29	90 50 90	

Cu Koza

76,082

120.454

142,128 152,076

100

0,7246

b) Determine o tamanho das partículas do metal, a área metálica e a dispersão metálica. Considere a largura a meia altura do pico mais intenso do metal, igual a 10° (2θ)

Determine the size of the metal particles, the metal area, and the metal dispersion. Consider the width at half height of the metal's most intense peak, equal to 10° (20)

2 θ	I /I _o	hkl	d	
36,48	75	111	2.46	CoO
42,38	100	200	2.13	CoO
44,14	100	111	2.05	Co 🖛
51,59	40	200	1.77	Co
61,50	50	220	1.51	CoO
73,65	20	311	1.28	CoO
76,08	30	220	1.25	Co
92,09	30	311	1.07	Co
98,08	10	222	1.02	Co

O metal é o Co (CoO é um óxido)

The **metal** is Co (CoO is an oxide)

O pico mais intenso do Co é o que tem $I/I_0 = 100$, ou seja $2\theta = 44.14^\circ$, logo $\theta = 22.07^\circ = 0.3852$ rad.

The **most intense peak** of Co is the one that has $I/I_0 = 100$, that has $2\theta = 44.14^\circ$, thus $\theta = 22.07^\circ = 0.3852$ rad.

$$\pi \text{ rad ----- } 180^{\circ}$$
 $\pi \text{ rad ----- } 5^{\circ}$

$$x = \pi \times 22.07/180 = 0.3852 \text{ rad}$$
 $x = \pi \times 5/180 = 0.0873 \text{ rad}$

Dados/Data

$$n_s = 1.51 \times 10^{19} \text{ atoms m}^{-2}$$

$$\rho = 8.9 \text{ g cm}^{-3}$$

$$M = 58.9 \text{ gmol}^{-1}$$

$$\lambda = 1.54 \,\text{Å}$$

$$\beta = 1$$

$$y = 1\% Co = 0.01$$

$$N = 6.023 \times 10^{23} \text{ atoms mol}^{-1}$$

A largura a meia altura (b) é 10° (2θ), ou seja 5° (θ) = 0.0873 rad.

The **full width at half maximum** is 10° (2θ), that is 5° (θ) = 0.0873 rad.

Logo: Thus:
$$dp = \frac{\beta \lambda}{b \cos \theta} = 1 \times 1.54 / [0.0873 \times \cos(0.3852)] = 19.04 \text{ Å}$$

$$dp = \frac{\beta \lambda}{b \cos \theta} = 1.54 / [0.0873 \times \cos(0.3852)] = 19.04 \text{ Å}$$

Para calcular a **área metálica**
$$S_M$$
: $dp = \frac{\beta \lambda}{b \cos \theta} = \frac{6 y}{\rho S_M}$
To calculate the **metal área** S_M :

$$S_M = (6 \times 0.01)/(8.9 \times 10^6 \text{gm}^{-3} \times 19.04 \times 10^{-10} \text{m}) = 3.53 \text{ m}^2/\text{g}$$

Dados / Data

$$n_s = 1.51 \times 10^{19} \text{ atoms m}^{-2}$$

$$\rho = 8.9 \text{ g cm}^{-3}$$

$$M = 58.9 \text{ gmol}^{-1}$$

$$\lambda = 1.54 \,\text{Å}$$

$$\beta = 1$$

$$y = 1\% Co = 0.01$$

$$N = 6.023 \times 10^{23} \text{ atoms mol}^{-1}$$

Para calcular a dispersão metálica:
$$D_M = \underbrace{S_M \ n_s}_{N \ y \ / \ M}$$

$$D_{M} = \frac{3.53 \text{ m}^{2}\text{g}^{-1} \times 1.51 \times 10^{19} \text{ atoms m}^{-2}}{6.023 \times 10^{23} \text{ atoms mol}^{-1} \times 0.01/58.9 \text{ gmol}^{-1}} = 0.52 = 52\%$$

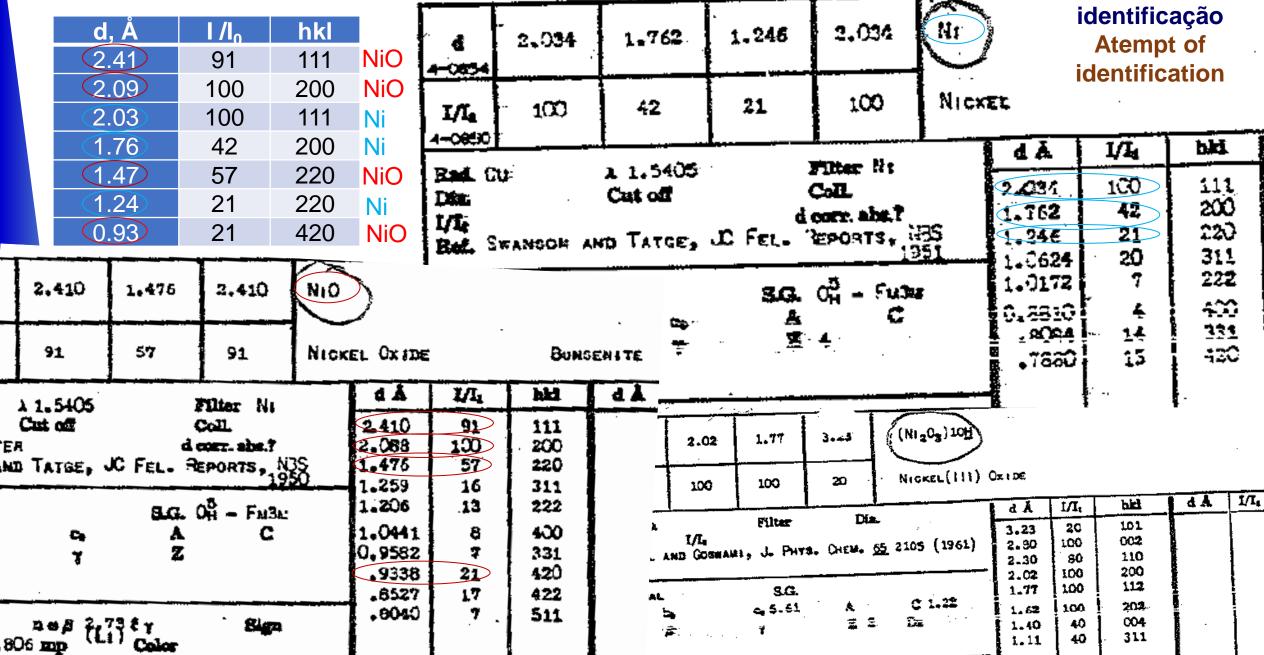
c) Como procederia para obter a área metálica usando outras técnicas de caracterização? Justifique.

How would you proceed to obtain the metallic area using other characterization techniques? Justify.

Microscopia eletrónica de transmissão para calcular o diâmetro das cristalites. Quimissorção para calcular dispersão e área metálica.

Transmission electron microscopy to calculate the diameter of crystallites. **Chemisorption** to calculate dispersion and metal area.

Exemplo – catalisador de níquel Example – nickel catalyst



Tentativa de

Determine o tamanho das partículas do metal, a área metálica e a dispersão metálica, considerando 1%Ni. Considere a largura a meia altura do pico mais intenso do metal 8° (2θ).

Determine the metal particle size, metal area, and metal dispersion by considering 1%Ni. Consider the full width at half height of the most intense peak of the metal to be equal to 8° (2 θ).

	d, Å		hkl	sen θ	θ, rad	
NiO	2.41	91	111	0.3195	0.3252	
NiO	2.09	100	200	0.3684	0.3773	
Ni	2.03	100	111	0.3793	0.3891	
Ni	1.76	42	200	0.4375	0.4528	
NiO	1.47	57	220	0.5238	0.5513	
Ni	1.24	21	220	0.6210	0.6700	
Ni	0.93	21	420	0.8280	0.9755	



$$n \lambda = 2 d sen\theta$$

 $d=(1.54 \text{ sen}\theta)/2 = 0.77 / \text{ sen } \theta \ (\theta \text{ in rad})$

sen $\theta = 0.77/d \Rightarrow \theta = arc sen (0.77/d)$

O metal é o Ni (NiO é um óxido)

The **metal** is Ni (NiO is an oxide)

O pico mais intenso do Ni é a $I/I_0 = 100$, ou seja d=2.03 Å. The most intense peak of Ni is at $I/I_0 = 100$, that is, d=2.03 Å.

A largura a meia altura (b) é 8° (2 θ), ou seja 4° (θ) = 0.06981 rad. The full width at half maximum is 8° (2 θ), ou seja 4° (θ) = 0.06981 rad.

Dados/Data:

$$n_s$$
 = 1.2×10¹⁹ atoms m⁻² ρ = 8.9 g cm⁻³; M = 58.7 gmol⁻¹ λ = 1.54 Å; β = 1 y = 1% Ni = 0.01 N = 6.023 ×10²³ atoms mol⁻¹

O diâmetro das cristalites fica:

The **crystallite diameters** is:

$$dp = \frac{\beta \lambda}{b \cos \theta} = 1 \times 1.54 / [0.06981 \times \cos(0.3891)] = 23.84 \text{ Å}$$

Dados/Data:

$$n_s$$
 = 1.2×10¹⁹ átomos m⁻²
 ρ = 8.9 g cm⁻³; M = 58.7 gmol⁻¹
 λ = 1.54 Å; β = 1
 y = 1% Ni = 0.01
N = 6.023 ×10²³ átomos mol⁻¹

$$\frac{dp}{b} = \frac{\beta \lambda}{b \cos \theta} = 1.54 / [0.06981 \times \cos(0.3891)] = 23.84 \text{ Å}$$

Para calcular a **área metálica S_M**:

To calculate the **metal área S_{M}**:

$$\frac{dp}{b} = \frac{\beta \lambda}{b \cos \theta} = \frac{6 y}{\rho S_M} \quad \frac{\log o}{\log o} \quad S_M = \frac{(6 \times 0.01)}{(8.9 \times 10^6 \text{gm}^{-3} \times 23.84 \times 10^{-10} \text{m})} = 2.83 \text{ m}^2/\text{g}$$

Outra maneira de determinar cos θ seria: $(sen \theta)^2 + (cos \theta)^2 = 1$

Another way to determine $\cos \theta$ would be: $\cos \theta = \sqrt{1-(\sin \theta)^2} = \sqrt{1-0.3793^2} = 0.9252$

Para calcular a dispersão metálica:

To calculate the **metal dispersion**:

$$\frac{D_{M} = \frac{S_{M} \cdot n_{s}}{N \cdot y / M} = \frac{2.83 \text{ m}^{2} \text{g}^{-1} \times 1.2 \times 10^{19} \text{ átomos m}^{-2}}{6.023 \times 10^{23} \text{átomos mol}^{-1} \times 0.01 / 58.7 \text{ gmol}^{-1}} = 0.331 = 33.1\%$$